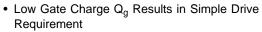


### HM5N50I-VB Datasheet

# N-Channel 650V (D-S) Super Junction Power MOSFET

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	650			
$R_{DS(on)}\left(\Omega\right)$	V <sub>GS</sub> = 10 V 0.95			
Q <sub>g</sub> (Max.) (nC)	15			
Q <sub>gs</sub> (nC)	3			
Q <sub>gd</sub> (nC)	6			
Configuration	Single			

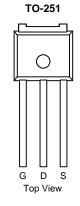
#### **FEATURES**

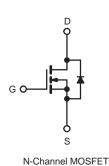




• Improved Gate, Avalanche and Dynamic dV/dt Ruggedness

- Fully Characterized Capacitance and Avalanche Voltage and Current
- Compliant to RoHS directive 2002/95/EC





ABSOLUTE MAXIMUM RATINGS T <sub>C</sub> = 25 °C, unless otherwise noted						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V <sub>DS</sub>	650	V	
Gate-Source Voltage			$V_{GS}$	± 30	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	
Continuous Drain Current <sup>e</sup>	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C	I <sub>D</sub>	5		
Continuous Drain Current	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 100 °C		4	Α	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	16		
Linear Derating Factor				1.67/0.8/0.3	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	120	mJ	
Repetitive Avalanche Current <sup>a</sup>			I <sub>AR</sub>	34	Α	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	17	mJ	
Maximum Power Dissipation $T_C = 25  ^{\circ}C$			P <sub>D</sub>	205/35/30	W	
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	00	
Soldering Recommendations (Peak Temperature) <sup>d</sup>	for	10 s		300	°C	
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
Mountaing Forque				1.1	N⋅m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Starting T $_J$  = 25 °C, L = 24 mH, R $_G$  = 25  $\Omega$ , I $_{AS}$  = 3.2 A (see fig. 12). c. I $_{SD} \le$  3.2 A, dI/dt  $\le$  90 A/ $\mu$ s, V $_{DD} \le$  V $_{DS}$ , T $_J \le$  150 °C.

- d. 1.6 mm from case.
- e. Drain current limited by maximum junction temperature.



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	62	°C/W		
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	3.6/1.2/0.6	C/VV		

PARAMETER	SYMBOL	TES	TEST CONDITIONS		TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> :	= 0 V, I <sub>D</sub> = 250 μA	650	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	Reference to 25 °C, I <sub>D</sub> = 1 mA <sup>d</sup>		0.6	-	mV/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	$I_{GSS}$	,	V <sub>GS</sub> = ± 30 V		-	± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>		V <sub>DS</sub> = 650 V, V <sub>GS</sub> = 0 V V <sub>DS</sub> = 520 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C		-	10 100	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 2.5 A <sup>b</sup>	-	0.95	-	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub>	= 50 V, I <sub>D</sub> = 2.5 A	8	-	-	S
Dynamic		1				l.	<u> </u>
Input Capacitance	C <sub>iss</sub>		V <sub>GS</sub> = 0 V,		320	-	
Output Capacitance	C <sub>oss</sub>		$V_{DS} = 25 \text{ V},$	-	75	-	1
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1	f = 1.0 MHz, see fig. 5		4	-	_
Output Capacitance	C <sub>oss</sub>		V <sub>DS</sub> = 1.0 V, f = 1.0 MHz	-	500	-	pF
		$V_{GS} = 0 V$	V <sub>DS</sub> = 520 V, f = 1.0 MHz	-	83	-	
Effective Output Capacitance	Coss eff.		V <sub>DS</sub> = 0 V to 520 V <sup>c</sup>	ı	14	-	
Total Gate Charge	$Q_g$		I <sub>D</sub> = 2.5 A, V <sub>DS</sub> = 400 V		-	15	nC
Gate-Source Charge	$Q_{gs}$	V <sub>GS</sub> = 10 V		-	-	3	
Gate-Drain Charge	$Q_{gd}$		see fig. 6 and 13 <sup>b</sup>		-	6	1
Turn-On Delay Time	t <sub>d(on)</sub>		V <sub>DD</sub> = 325 V, I <sub>D</sub> = 3.2 A		18	-	
Rise Time	t <sub>r</sub>				40	-	ns
Turn-Off Delay Time	t <sub>d(off)</sub>	$R_G = 9.1 \Omega$ , $R_D = 62 \Omega$ , see fig. $10^b$		-	50	-	
Fall Time	t <sub>f</sub>			-	30	-	
<b>Drain-Source Body Diode Characteristic</b>	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	showing the	/   L		-	5	- A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	integral reverse p - n junction diode		-	-	16	
Body Diode Voltage	$V_{SD}$	$T_J = 25  ^{\circ}\text{C},  I_S = 3.2  \text{A},  V_{GS} = 0  \text{V}^{\text{b}}$		-	-	1.5	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = 3.2 A, dI/dt = 100 A/μs <sup>b</sup>		-	180	-	ns
Body Diode Reverse Recovery Charge	$Q_{rr}$			-	2.1	3.2	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by $L_{\mbox{\scriptsize S}}$ and $L_{\mbox{\scriptsize D}}$ )				L <sub>D</sub> )	

#### **Notes**

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %.
- c.  $C_{oss}$  eff. is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DS}$ .
- d. t = 60 s, f = 60 Hz.



#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

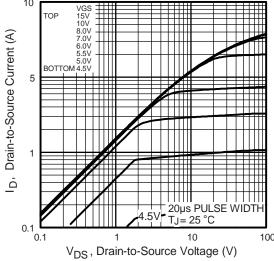


Fig. 1 - Typical Output Characteristics

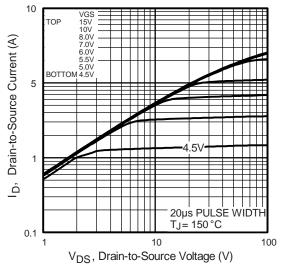


Fig. 2 - Typical Output Characteristics

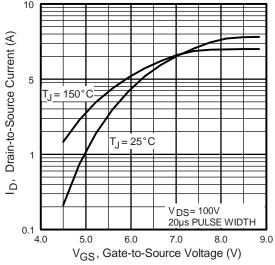


Fig. 3 - Typical Transfer Characteristics

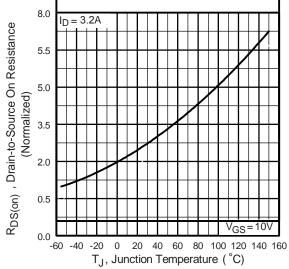


Fig. 4 - Normalized On-Resistance vs. Temperature



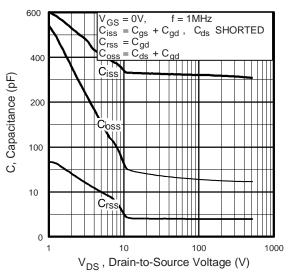


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

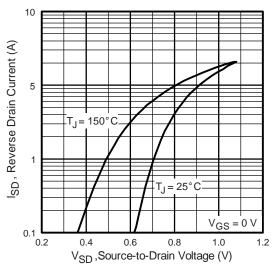


Fig. 7 - Typical Source-Drain Diode Forward Voltage

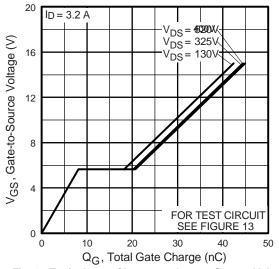


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

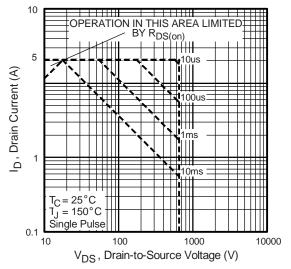


Fig. 8 - Maximum Safe Operating Area



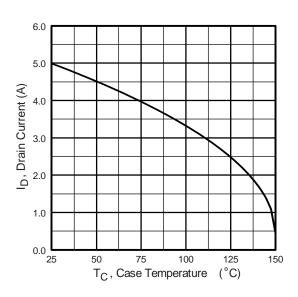


Fig. 9 - Maximum Drain Current vs. Case Temperature

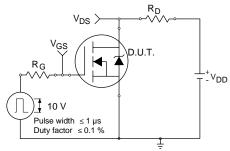


Fig. 10a - Switching Time Test Circuit

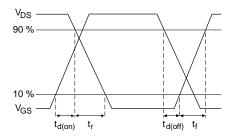


Fig. 10b - Switching Time Waveforms

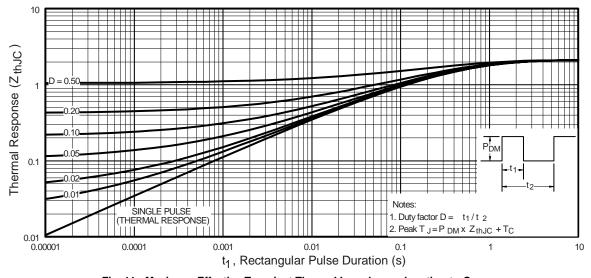


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

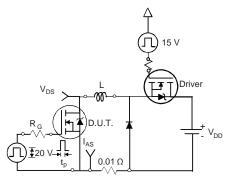


Fig. 12a - Unclamped Inductive Test Circuit

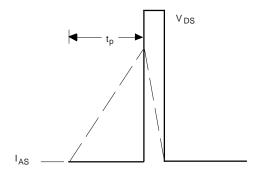


Fig. 12b - Unclamped Inductive Waveforms



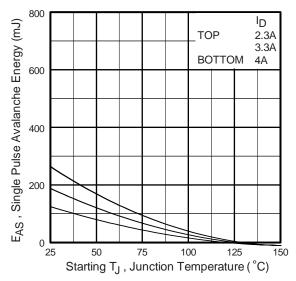


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

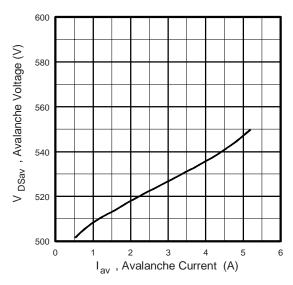


Fig. 12d - Typical Drain-to Source Voltage vs. Avalanche Current

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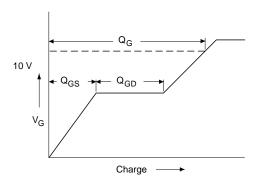


Fig. 13a - Basic Gate Charge Waveform

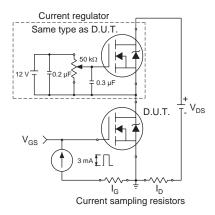
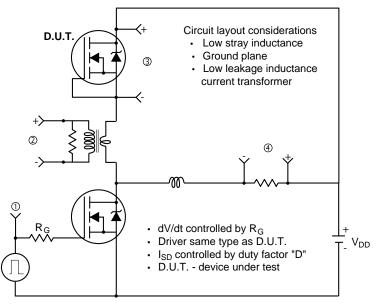


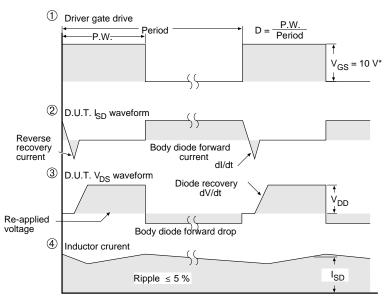
Fig. 13b - Gate Charge Test Circuit



7

## Peak Diode Recovery dV/dt Test Circuit





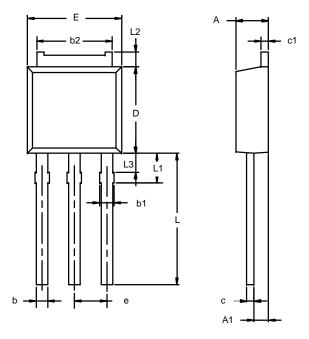
\*  $V_{GS} = 5 V$  for logic level devices

Fig. 14 - For N-Channel



### TO-251AA (DPAK)

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Note: Dimension L3 is for reference only.

	MILLIM	IETERS	INC	HES		
Dim	Min	Max	Min	Max		
Α	2.21	2.38	0.087	0.094		
A1	0.89	1.14	0.035	0.045		
b	0.71	0.89	0.028	0.035		
b1	0.76	1.14	0.030	0.045		
b2	5.23	5.43	0.206	0.214		
С	0.46	0.58	0.018	0.023		
с1	0.46	0.58	0.018	0.023		
D	5.97	6.22	0.235	0.245		
Е	6.48	6.73	0.255	0.265		
е	2.28	BSC	0.090	BSC		
L	8.89	9.53	0.350	0.375		
L1	1.91	2.28	0.075	0.090		
L2	0.89	1.27	0.035	0.050		
L3	1.15	1.52	0.045	0.060		
ECN: S-03946—Rev. E, 09-Jul-01						

ECN: S-03946—Rev. E, 09-Jul-01 DWG: 5346



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